P R Bingham

List of Publications by Year in descending order

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1478280 940416 33 351 16 6 citations h-index g-index papers 37 37 37 372 docs citations times ranked citing authors all docs

#	Article	IF	CITATIONS
1	Preprocessing for Unintended Conducted Emissions Classification with ResNet. Applied Sciences (Switzerland), 2021, 11, 8808.	1.3	O
2	A high-pressure flow through test vessel for neutron imaging and neutron diffraction-based strain measurement of geological materials. Review of Scientific Instruments, 2020, 91, 084502.	0.6	3
3	Single crystal to polycrystal neutron transmission simulation. Review of Scientific Instruments, 2018, 89, 025103.	0.6	12
4	Fragmentation of copper current collectors in Li-ion batteries during spherical indentation. Journal of Power Sources, 2017, 364, 432-436.	4.0	21
5	Spontaneous imbibition of water and determination of effective contact angles in the Eagle Ford Shale Formation using neutron imaging. Journal of Earth Science (Wuhan, China), 2017, 28, 874-887.	1.1	32
6	Neutron Radiography of Fluid Flow for Geothermal Energy Research. Physics Procedia, 2015, 69, 464-471.	1.2	4
7	Magnified Neutron Radiography with Coded Sources. Physics Procedia, 2015, 69, 218-226.	1.2	5
8	Magnified neutron radiography with coded sources. Proceedings of SPIE, 2014, , .	0.8	3
9	Iterative Reconstruction of Coded Source Neutron Radiographs. IEEE Transactions on Nuclear Science, 2013, 60, 1624-1631.	1.2	2
10	Neutron imaging for geothermal energy systems. , 2013, , .		1
11	Neutron imaging with coded sources: design pitfalls and the implementation of a simultaneous iterative reconstruction technique. , 2013 , , .		2
12	Non-uniform contrast and noise correction for coded source neutron imaging. Proceedings of SPIE, 2012, , .	0.8	5
13	Iterative reconstruction of coded source neutron radiographs. , 2012, , .		0
14	Coded source neutron imaging., 2011,,.		6
15	Coded source neutron imaging at the PULSTAR reactor. Nuclear Instruments and Methods in Physics Research, Section A: Accelerators, Spectrometers, Detectors and Associated Equipment, 2011, 652, 606-609.	0.7	4
16	Dual modality live cell imaging with multiple-wavelength digital holography and epi-fluorescence. 3D Research, 2011, 2, 1.	1.8	12
17	Automatic firearm class identification from cartridge cases. Proceedings of SPIE, 2011, , .	0.8	2
18	Investigation of coded source neutron imaging at the north carolina state university PULSTAR reactor. , 2009, , .		3

#	Article	IF	Citations
19	Mathematics of Neutron Imaging. Neutron Scattering Applications and Techniques, 2009, , 109-127.	0.2	5
20	Quantitative phase imaging by three-wavelength digital holography. Optics Express, 2008, 16, 9753.	1.7	165
21	Three-Wavelength Phase Imaging Digital Holography of MEMS Motion. , 2008, , .		O
22	Optical spatial heterodyned interferometry for inspection of microelectromechanical systems. , 2007, , .		1
23	Improving resolution in microscopic holography by computationally fusing multiple, obliquely illuminated object waves in the Fourier domain. Applied Optics, 2007, 46, 827.	2.1	28
24	<title>Optical Spatial Heterodyned Interferometry for Applications in Semiconductor Inspection and Metrology</title> ., 2006,,.		2
25	Semiconductor sidewall shape estimation. Journal of Electronic Imaging, 2004, 13, 474.	0.5	3
26	Spatial heterodyne interferometry techniques and applications in semiconductor wafer manufacturing. , 2004, , .		1
27	Phase defect detection with spatial heterodyne interferometry. , 2004, , .		1
28	Detection of cavitation pits on steel surfaces using SEM imagery. , 2003, , .		0
29	Semiconductor sidewall shape estimation using top-down CD-SEM image retrieval. , 2003, , .		0
30	Preliminary results for mask metrology using spatial heterodyne interferometry., 2003, 5256, 1331.		3
31	Estimating cross-section semiconductor structure by comparing top-down SEM images., 2003,,.		7
32	Sidewall structure estimation from CD-SEM for lithographic process control., 2003,,.		7
33	<title>Direct to digital holography for semiconductor wafer defect detection and review</title> ., 2002, 4692, 180.		10